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**THE WORLD'S RESOURCE FOR
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Phonon characteristics and photoluminescence of bamboo structured silicon-doped boron nitride multiwall nanotubes

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Bamboo structured silicon-doped boron nitride multiwall nanotubes are synthesized via catalyst-assisted pyrolysis of a boron-containing polymeric precursor. The nanotubes are characterized using transmission electron microscopy, x-ray diffraction, Raman, and Fourier-transformed infrared spectroscopy. The results suggest that the Si dopants cause significant changes in the structure and phonon characteristics of the nanotubes as compared to pure boron nitride nanotubes. A broad photoluminescence band ranging between 500 and 800 nm is observed from the nanotubes, which is attributed to Si dopants. Study on temperature dependence of emission intensity suggests that the thermal activation energy of the nonradiative recombination process is 35 meV. © 2007 American Institute of Physics. [DOI: 10.1063/1.2429904]

Boron nitride nanotubes (BNNTs), which are thermally stable and chemically inert, have attracted extensive attention in recent years for their potential applications in nano-electronic and nanophotonic devices.^{1–3} Theoretical calculation predicted that where the diameter of BNNTs is larger than a certain value (~ 10 B–N units), band gaps of the tubes are approximately equal to that of bulk hexagonal BN (*h*-BN), and almost independent of their radius and chirality, and whether they are single or multiwalled.^{4,5} The electronic structures of BNNTs can be tailored by doping. Previous studies on carbon-doped BNNTs demonstrated that their electronic properties were primarily determined by composition.^{6,7} Phonon characteristics and luminescence properties of BNNTs have also been studied to obtain a better understanding of their properties and detailed structures.^{8,9} However, all previous works were focused on either pure or carbon-doped BNNTs.

In this letter, we report studies on Si-doped multiwall boron nitride nanotubes (Si-BNNTs). While both silicon and carbon belong to the same IV group, silicon has no sp^2 hybridization. Consequently, a fundamentally different effect is expected between silicon doping and carbon doping.

The Si-BNNTs were synthesized by pyrolysis of a boron-modified polymeric precursor in the presence of FeCl_2 as the catalyst.¹⁰ The precursor was first mixed with 5 wt % FeCl_2 powder using high energy ball milling. The mixture was then annealed in a tube furnace at 1350 °C for 3 h in N_2 . During the annealing, the precursor was first decomposed to amorphous silicoboron carbonitride powder at 1000 °C,¹¹ which was then reacted with the Fe to form Si–C–B–Fe liquid alloy droplets at temperatures higher than the eutectic point of the system. The nanotubes were precipitated and grew from the droplets through reaction between B in

the droplets and N_2 in the environment. Figure 1(a) shows a typical transmission electron microscopy (TEM) image of the bamboo structured Si-BNNTs, which are 80–200 nm in diameter and up to a few micrometers in length.¹⁰ Energy-dispersive x-ray spectroscopy analysis reveals that the nanotubes consist of uniformly distributed B, N, and Si with the B-to-N-to-Si ratio of 1:1:0.06.¹⁰ Figures 1(b)–1(d) are high

FIG. 1. (a) TEM image of the bamboo structured Si-BNNTs; [(b)–(d)] HR-TEM images of the areas marked in (a) showing the detailed structure of the Si-BNNTs; (e) XRD pattern of the Si-BNNTs.

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FIG. 2. Room-temperature Raman spectrum of the Si-BNNTs.

resolution TEM (HRTEM) images recorded from the areas marked in Fig. 1(a), showing the detailed structure of the Si-BNNTs. The interplane spacing measured from the HRTEM image is ~ 0.37 nm [Fig. 1(c)], which is larger than that measured in bulk hexagonal/rhombohedral BN¹² and stoichiometric BN nanotubes of 0.333 nm.¹³ The in-plane [(100) planes] lattice spacing measured from the HRTEM image is ~ 0.25 nm [Fig. 1(d)], which is consistent with that measured from the x-ray diffraction (XRD) pattern [Fig. 1(e)]. This value is larger than that measured from pure BN nanotubes (0.22 nm).^{14,15} The larger values of fringe spacing are likely due to the silicon doping.

Raman spectrum of the Si-BNNTs was collected using an UV-lamp spectroscopy with a 30 mW Ar⁺ laser (488 nm) as the excitation source (Fig. 2). The dominant peak near 1357 cm⁻¹ is attributed to the well-known in-plane counter-phase B–N vibration mode (E_{2g}).^{16,17} The mode was previously observed for single-crystalline bulk *h*-BN at 1366 cm⁻¹.^{8,18} Theoretical studies^{19–21} predicted a curvature-induced softening for the E_{2g} mode when *h*-BN sheets were rolled up into nanotubes. About a 2 cm⁻¹ downward shift was observed in high-purity BNNTs of 50 nm in diameter.⁹ Thereby, the curvature-induced softening by itself cannot account for the current shift (~ 9 cm⁻¹) since the curvature (tube diameter and cap area) of the current Si-BNNTs is relatively large. Here we attribute the shift to Si doping. The size (larger than B) and relatively high concentration of Si dopants in the Si-BNNTs could cause an increase in average bond length and a disturbance in an otherwise perfect BN structure, thus leading to a significant softening effect. It is interesting to note that the effect of Si doping is different from C doping that caused the peak 2.1 cm⁻¹ blueshift compared to bulk *h*-BN.⁸ The full width at half maximum of the peak is about 28 cm⁻¹, which is remarkably wider than that observed in single-crystalline bulk *h*-BN (8 cm⁻¹).¹⁸ The value is also wider than those observed in pure BNNTs (~ 13 cm⁻¹)⁹ and C-doped BNNTs (~ 18 cm⁻¹).⁸ The value is close to the upper end observed in chemical vapor deposition *h*-BN (16–30 cm⁻¹),^{16,22} which is characterized by a large amount of defects. Therefore, the current peak broadening is likely due to the Si doping and defects, such as partial/bent walls observed in the Si-BNNTs.

Fourier transformation infrared (FTIR) spectrum of the Si-BNNTs was recorded using a Bio-Rad FTS-3000 FTIR spectroscopy (Fig. 3). The spectrum consists of four dominant peaks at 818, 1241, 1389, and 1545 cm⁻¹, and a pronounced shoulder at 1120 cm⁻¹. The peak at 818 cm⁻¹,

FIG. 3. Room-temperature FTIR spectrum of the Si-BNNTs.

which has an asymmetric shape with a peak at 818 cm⁻¹ and a shoulder at 780 cm⁻¹, can be assigned to the out-of-plane A_{2u} mode with transverse optical (TO)-longitudinal optical (LO) splitting.^{9,22,23} The position of the peak at 1389 cm⁻¹ is higher than the in-plane E_{1u} (TO) mode observed in the pyrolytic *h*-BN (1367 cm⁻¹),²² the polycrystalline bulk *h*-BN (1377 cm⁻¹),²³ and pure BNNTs [1366 (Ref. 9) and 1372 cm⁻¹ (Ref. 23)], but lower than that in *h*-BN monolayers epitaxially deposited on metal surfaces (1395 cm⁻¹),²⁴ which showed a buckled structure with some sp^3 admixture. Considering the sp^3 hybridization of Si dopants and the curvature in the cap area, the peak at 1389 cm⁻¹, which shows an asymmetric shape with a peak at 1389 cm⁻¹ and a shoulder at 1358 cm⁻¹, can be attributed to the E_{1u} (TO) mode from the cap area (1358 cm⁻¹) and from the wall area (1389 cm⁻¹) of the bamboo structure. The softening effect is likely from the Si doping, similar to the Raman-active mode discussed above. Previous studies on pure BNNTs suggested that the peak near 1540 cm⁻¹ is from the softened E_{1u} (LO) (1610 cm⁻¹ in pyrolytic *h*-BN without softening²²) due to the curvature effect.²³ We can attribute the peak at 1545 cm⁻¹ to the same origin. The origin of the peak at 1241 cm⁻¹ and the shoulder at 1120 cm⁻¹ in the FTIR spectrum (Fig. 3), which have not been observed previously in *h*-BN materials, is not clear to us at this moment. It is suspected that they are related to the Si doping, which have sp^3 hybridization.

The photoluminescence (PL) spectrum of the Si-BNNTs was measured under the excitation of an Ar⁺ laser (488 nm). Figure 4(a) shows a typical PL spectrum obtained at 300 K, which shows an intense broad emission band from 500 to 800 nm (sharp peaks at the high and low energy sides are due to Raman scattering). As mentioned previously, the band gaps of the BNNTs are approximately equal to that of bulk *h*-BN and independent of their radius and chirality when the tubes are large enough.^{4,5} Previous study on the cathode luminescence of pure multiwall BNNTs of ~ 50 nm revealed an emission peak at 3.3 eV with a shoulder at 4.1 eV.⁹ Wu *et al.* reported a wide PL peak ranging between 3.5 and 4.2 eV centered at 4.02 eV from C-doped BNNTs.⁸ Here we tentatively attribute the PL to Si doping. Si atoms have one extra electron as compared to B, which should result in a donor level within the band gap. In addition, point defects associated with Si and/or N can further modify the energy levels within the band gap, as in silicon nitride materials.²⁵

The temperature dependence of PL was measured in a temperature range of 84–300 K. The position and shape of

FIG. 4. (a) Room-temperature PL spectrum of the Si-BNNTs; (b) Emission intensity as a function of temperature.

the emission bands are almost independent of temperature in the above range. The intensities of the peaks decrease rapidly with increasing temperature. The temperature dependence of integrated emission intensity can be fitted by the expression [Fig. 4]²⁶

$$I(T) = I_0 / [1 + v_0/v_R \exp(-\Delta E/K_B T)], \quad (1)$$

where $I(T)$ is the integrated PL intensity at temperature T , I_0 is the intensity at $T=0$ K, v_0 and v_R are the nonradiative and radiative recombination rates, respectively, and ΔE is the thermal activation energy of the nonradiative emission. The best fit to experimental data gives $\Delta E=35$ meV. While the exact band structures are not clear, such small activation energy can only be related to the unpaired electron in Si, further proving that the PL is from Si doping.

In summary, bamboo structured Si-doped BNNTs have been synthesized via catalyst-assisted pyrolysis of a polymeric precursor. Raman and FTIR techniques have been used to characterize the phonon features of the nanotubes. Both methods reveal a significant effect from Si dopants and bam-

boo structure. Intense visible PL emission has been observed from the Si-BNNTs in the range between 500 and 800 nm. The emission is attributed to Si doping. Given that Si is more stable than C (e.g., C can be removed by oxidation⁸), Si may have an advantage as a doping element compared to C.

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